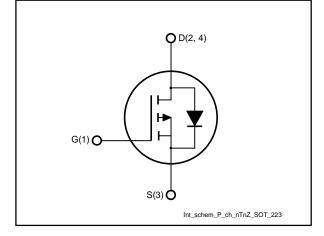


Datasheet - production data

## P-channel -60 V, 0.13 Ω typ., -3 A STripFET™ F6 Power MOSFET in a SOT-223 package

4 2 3 SOT-223

Figure 1: Internal schematic diagram



### Features

Order code	VDS	R <sub>DS(on)</sub> max.	ID
STN3P6F6	-60 V	0.16 Ω	-3 A

- Very low on-resistance
- Very low gate charge
- High avalanche ruggedness
- Low gate drive power loss

### **Applications**

• Switching applications

### Description

This device is a P-channel Power MOSFET developed using the STripFET<sup>TM</sup> F6 technology, with a new trench gate structure. The resulting Power MOSFET exhibits very low R<sub>DS(on)</sub> in all packages.

#### Table 1: Device summary

Order code	Marking	Package	Packing
STN3P6F6	3P6F6	SOT-223	Tape and reel

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This is information on a product in full production.

### Contents

### Contents

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## 1 Electrical ratings

 Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage	-60	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
lD	Drain current (continuous) at T <sub>pcb</sub> = 25 °C	-3	А
ID	Drain current (continuous) at T <sub>pcb</sub> = 100 °C	-2	А
Idm	Drain current (pulsed)	-12	А
Ртот <sup>(1)</sup>	Total dissipation at $T_{pcb} = 25 \text{ °C}$	2.6	W
Tj	T <sub>j</sub> Operating junction temperature range		°C
T <sub>stg</sub>	Storage temperature range	- 55 to 175	°C

#### Notes:

 $^{(1)}\mbox{Pulse}$  width is limited by safe operating area

Table 3	: Thermal	data
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Symbol	Parameter	Value	Unit
R <sub>thj-pcb</sub> <sup>(1)</sup>	Rthj-pcb <sup>(1)</sup> Thermal resistance junction-pcb		°C/W

#### Notes:

 $^{(1)}\!When$  mounted on FR-4 board of 1 inch², 2 Oz Cu, t<10 s



## 2 Electrical characteristics

(Tc= 25 °C unless otherwise specified)

Table 4: On/off states						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage(V <sub>GS</sub> = 0)	I <sub>D</sub> = -250 μA	-60			V
I	Zero gate voltage Drain current	V <sub>DS</sub> = -60 V			-1	μA
IDSS (VGS= 0)		$V_{DS} = -60 \text{ V}, \text{ T}_{C} = 125 \text{ °C}^{(1)}$			-10	μA
lgss	Gate-body leakage current	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$	-2		-4	V
RDS(on)	Static drain-source on- resistance	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -1.5 \text{ A}$		0.13	0.16	Ω

Notes:

<sup>(1)</sup>Defined by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	340	-	pF
Coss	Output capacitance	V <sub>DS</sub> = -48 V, f = 1 MHz, V <sub>GS</sub> = 0		40	-	pF
Crss	Reverse transfer capacitance	100 - 0	-	20	-	pF
Qg	Total gate charge $V_{DD} = -48 \text{ V}, \text{ I}_D = -3 \text{ A},$		-	6.4	-	nC
Qgs	Gate-source charge	$V_{GS} = -10 V$	-	1.7	-	nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 14: "Gate charge test circuit")		1.7	-	nC

#### Table 5: Dynamic

#### Table 6: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD} = -48 \text{ V}, \text{ I}_{D} = -1.5 \text{ A},$	-	6.4	-	ns
tr	Rise time	$R_G = 4.7 \Omega$ , $V_{GS} = -10 V$ (see Figure 13: "Switching	-	5.3	-	ns
t <sub>d(off)</sub>	Turn-off delay time	times test circuit for	-	14	-	ns
tŕ	Fall time	resistive load")	-	3.7	-	ns



#### Electrical characteristics

	Table 7: Source drain diode						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
Isd	Source-drain current		-		-3	А	
Isdm <sup>(1)</sup>	Source-drain current (pulsed)12				А		
V <sub>SD</sub> (2)	Forward on voltage $I_{SD} = -3 \text{ A}, V_{GS} = 0$		-		-1.1	V	
trr	Reverse recovery time	I <sub>SD</sub> = -5 A,	-	20		ns	
Qrr	Reverse recovery charge	di/dt = 100 A/µs, V <sub>DD</sub> = - 16 V,T <sub>i</sub> = 150 °C	-	17.8		nC	
I <sub>RRM</sub>	Reverse recovery current	(see Figure 15: "Test circuit for inductive load switching and diode recovery times")	-	-1.8		A	

#### Notes:

 $\ensuremath{^{(1)}}\xspace$  Pulse width limited by safe operating area.

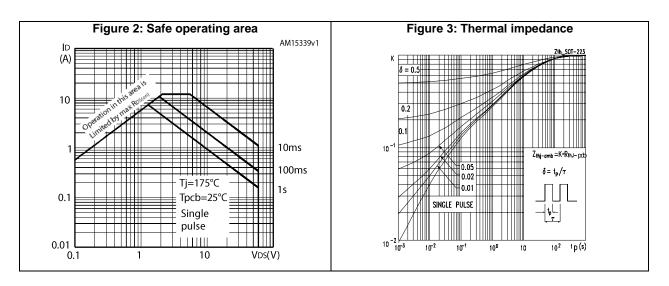
 $^{(2)}\text{Pulse}$  duration = 300 µs, duty cycle 1.5%

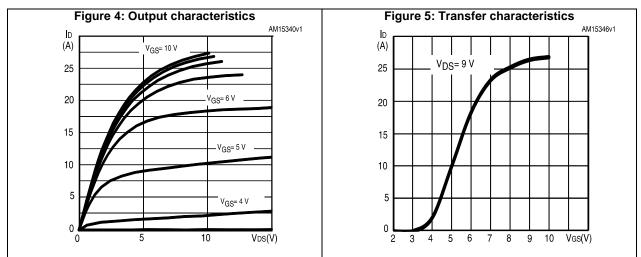


### 2.1 Electrical characteristics (curves)



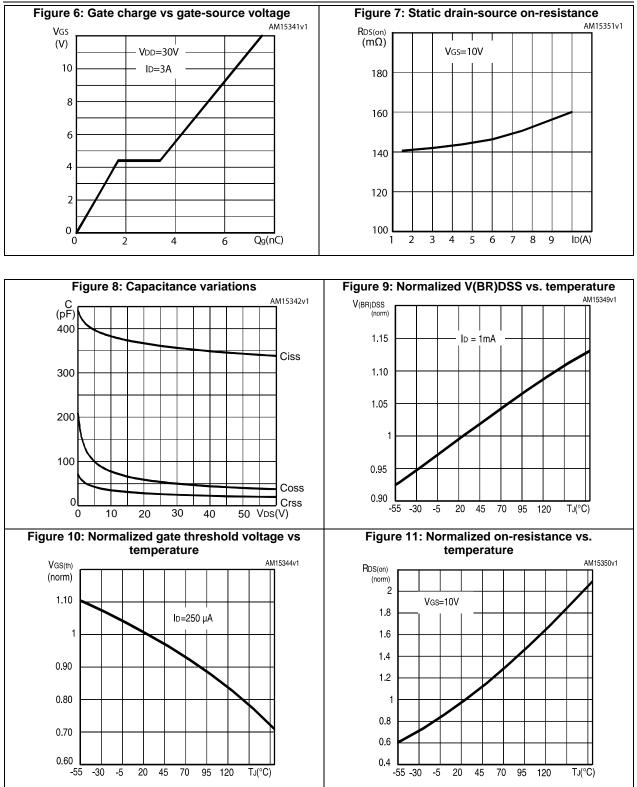
For the P-channel Power MOSFET, current polarity of voltages and current have to be reversed .







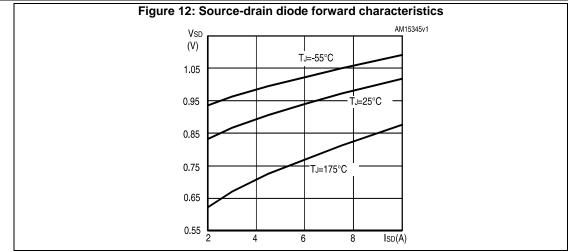
#### **Electrical characteristics**



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#### **Electrical characteristics**

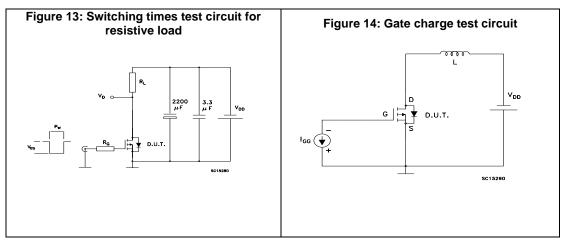
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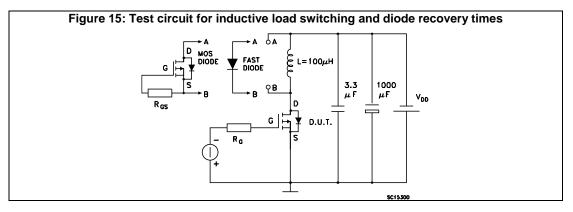


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### 3 Test circuits







## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.

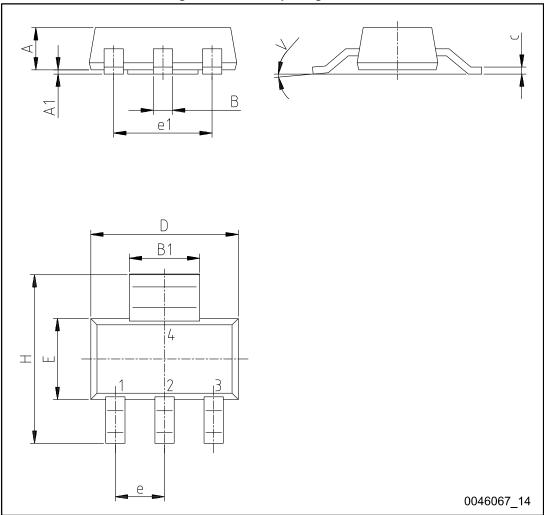
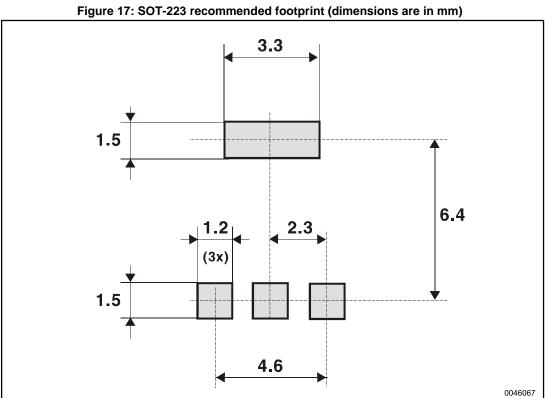


Figure 16: SOT-223 package outline



#### Package information

	Table 8: SOT-223 package mechanical data			
Dim		mm		
Dim.	Min.	Тур.	Max.	
A			1.8	
A1	0.02		0.1	
В	0.6	0.7	0.85	
B1	2.9	3	3.15	
С	0.24	0.26	0.35	
D	6.3	6.5	6.7	
е		2.3		
e1		4.6		
E	3.3	3.5	3.7	
Н	6.7	7.0	7.3	
V			10º	



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## 5 Revision history

Table 9: Document revision history

Date	Revision	Changes
31-Oct-2012	1	First release.
09-Nov-2012	2	Modified: note 1 in Table 3
16-Jan-2013	3	Document status promoted from preliminary data to production data
14-Mar-2013	4	Modified: Figure 1, 3, Ciss, Coss, Crss typical values in Table 5
07-Oct-2016	5	Updated title, features and description in cover page. Updated silhouette and <i>Figure 1: "Internal schematic diagram"</i> . Updated <i>Figure 16: "SOT-223 package outline"</i> . Minor text changes.



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